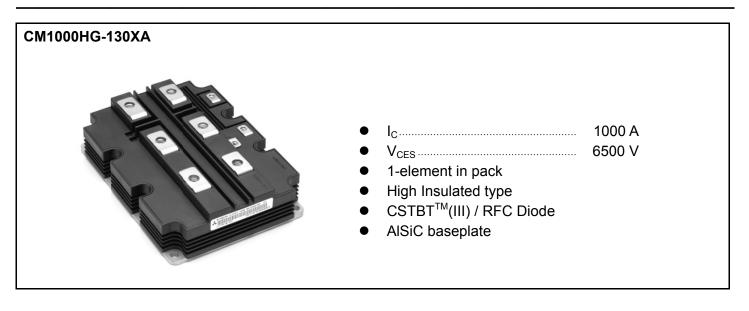


<High Voltage Insulated Gate Bipolar Transistor: HVIGBT >

CM1000HG-130XA

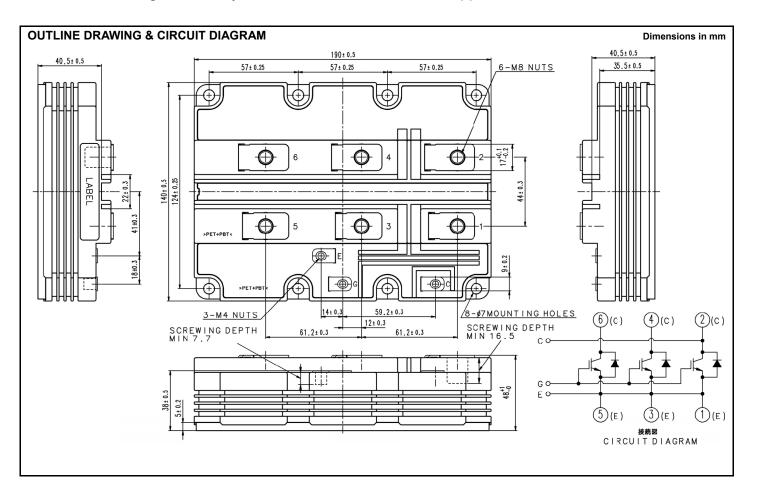
HIGH POWER SWITHCHING USE INSULATED TYPE

5th-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules



APPLICATION

Traction drives, High Reliability Converters / Inverters, DC choppers



Publication Date : November 2015

(HVM-1072-B)

MAXIMUM RATINGS

| Symbol | Item | Conditions | Ratings | Unit |
|------------------|--------------------------------------|---|--------------------|------|
| V _{CES} | | $V_{GE} = 0 \text{ V}, T_j = +150 ^{\circ}\text{C}$ | 6500 | |
| | Collector-emitter voltage | $V_{GE} = 0 \text{ V}, T_j = 25 ^{\circ}\text{C}$ | 6300 | V |
| | | $V_{CE} = 0 \text{ V}, T_j = -50 \text{ °C}$ | 5700 | |
| V_{GES} | Gate-emitter voltage | $V_{CE} = 0 \text{ V}, T_j = 25 \text{ °C}$ | ± 20 | V |
| Ic | | DC, T _C = 100 °C | 1000 | Α |
| I _{CRM} | Collector current | Pulse (Note 1) | 2000 | Α |
| I _E | Emitter current (44.4.6) | DC, T _C = 85 °C | 1000 | Α |
| I _{ERM} | Emitter current (Note 2) | Pulse (Note 1) | 2000 | Α |
| P _{tot} | Maximum power dissipation (Note 3) | T _c = 25 °C, IGBT part | 11300 | W |
| V _{iso} | Isolation voltage | RMS, sinusoidal, f = 60 Hz, t = 1 min. | 10200 | V |
| V _e | Partial discharge extinction voltage | RMS, sinusoidal, f = 60 Hz, Q _{PD} ≤ 10 pC | 5100 | V |
| Tj | Junction temperature | | − 50 ~ +150 | °C |
| T _{jop} | Operating junction temperature | | − 50 ~ +150 | °C |
| T _{stg} | Storage temperature | | − 55 ~ +150 | °C |

ELECTRICAL CHARACTERISTICS

| Symbol | Item | Conditions | | | Limits | | Unit |
|-----------------------|--------------------------------------|---|-------------------------|------|--------|----------|-------|
| Symbol | item | Conditions | | Min | Тур | Max | Offic |
| | | | T _j = 25 °C | _ | _ | 5.0 | |
| I _{CES} | Collector cutoff current | $V_{CE} = V_{CES}, V_{GE} = 0 V$ | T _j = 125 °C | - | 5.0 | _ | mA |
| | | | T _j = 150 °C | - | 30.0 | _ | |
| $V_{GE(th)}$ | Gate-emitter threshold voltage | V_{CE} = 10 V, I_{C} =100 mA, T_{j} = 25 °C | | 5.70 | 6.50 | 7.30 | V |
| I _{GES} | Gate leakage current | $V_{GE} = V_{GES}$, $V_{CE} = 0V$, $T_j = 25$ °C | | -0.5 | _ | 0.5 | μΑ |
| C _{ies} | Input capacitance | $V_{CF} = 10 \text{ V}, V_{GF} = 0 \text{ V}, f = 100 \text{ kHz}$ | | | 216 | _ | nF |
| Coes | Output capacitance | $V_{CE} = 10 \text{ V}, V_{GE} = 0 \text{ V}, 1 = 100 \text{ kHz}$ $T_i = 25 \text{ °C}$ | | | 7.2 | _ | nF |
| C _{res} | Reverse transfer capacitance | 1 _j - 23 C | | _ | 0.81 | _ | nF |
| Q_G | Total gate charge | $V_{CC} = 3600 \text{ V}, I_{C} = 1000 \text{ A}, V_{GE} = \pm 15$ | V | _ | 16.5 | _ | μC |
| | | I _C =1000 A ^(Note 4) | T _j = 25 °C | _ | 2.60 | _ | |
| V_{CEsat} | Collector-emitter saturation voltage | V _{GE} = 15 V | T _j = 125 °C | - | 3.40 | 4.30 | V |
| | | V _{GE} = 15 V | T _j = 150 °C | _ | 3.60 | _ | |
| | Turn-on delay time | | T _j = 25 °C | _ | _ | _ | |
| $t_{d(on)}$ | | | T _j = 125 °C | _ | 1.70 | _ | μs |
| | | | T _i = 150 °C | _ | 1.70 | 2.60 | |
| | Turn-on rise time | V _{cc} = 3600 V | T _i = 25 °C | _ | _ | _ | μs |
| t _r | | I _C = 1000 A | T _i = 125 °C | _ | 0.30 | _ | |
| | | V _{GE} = ±15 V | T _i = 150 °C | _ | 0.30 | 0.60 | |
| | | $R_{G(on)} = 1.8 \Omega$ | T _i = 25 °C | _ | _ | _ | |
| E _{on(10%)} | Turn-on switching energy (Note 5) | L _s = 150 nH | T _i = 125 °C | _ | 7.00 | _ | J |
| , , | 5 5, | Inductive load | T _i = 150 °C | _ | 7.50 | _ | |
| | | | T _i = 25 °C | _ | _ | _ | |
| E _{on} | Turn-on switching energy (Note 6) | | T _i = 125 °C | _ | 7.40 | _ | J |
| | | | T _i = 150 °C | _ | 7.90 | _ | |
| | | | T _i = 25 °C | _ | _ | _ | |
| $t_{d(off)}$ | Turn-off delay time | | T _i = 125 °C | _ | 10.0 | _ | μs |
| | | | T _i = 150 °C | _ | 10.0 | 15.0 | |
| | | V _{CC} = 3600 V | T _i = 25 °C | _ | _ | _ | |
| t _f | Turn-off fall time | I _C = 1000 A | T _i = 125 °C | _ | 0.6 | _ | μs |
| 1 | | $V_{GE} = \pm 15 \text{ V}$ | T _i = 150 °C | _ | 0.7 | 1.4 | i i |
| | | $R_{G(off)} = 30 \Omega$ | T _i = 25 °C | _ | _ | _ | |
| E _{off(10%)} | Turn-off switching energy (Note 5) | L _s = 150 nH | T _i = 125 °C | _ | 6.40 | _ | J |
| —JII(10%) | | Inductive load | T _i = 150 °C | _ | 6.80 | _ | |
| | | | T _i = 25 °C | _ | _ | <u> </u> | |
| E _{off} | Turn-off switching energy (Note 6) | | T _i = 125 °C | _ | 6.80 | — | J |
| ⊏ _{off} | | | T _i = 150 °C | _ | 7.30 | _ | |
| | | , | 1 1 100 0 | | 7.50 | | |

INSULATED TYPE

5th-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules

ELECTRICAL CHARACTERISTICS (continuation)

| Complete | lka-ra | Canaditiana | Conditions | | | Linit | |
|-----------------------|---|---|-------------------------|-----|------|-------|------|
| Symbol | Item | Conditions | | Min | Тур | Max | Unit |
| | Emitter-collector voltage (Note 2) | I _E = 1000 A ^(Note 4) | T _j = 25 °C | _ | 2.70 | _ | |
| V_{EC} | | V _{GF} = 0 V | T _j = 125 °C | _ | 3.00 | 3.70 | V |
| | | VGE - U V | T _j = 150 °C | _ | 3.05 | _ | |
| | | | T _j = 25 °C | _ | _ | _ | |
| t _{rr} | Reverse recovery time (Note 2) | | T _j = 125 °C | _ | 2.10 | _ | μs |
| | | | T _j = 150 °C | _ | 2.20 | _ | |
| | | | T _j = 25 °C | _ | _ | _ | |
| Irr | Reverse recovery current (Note 2 | V _{CC} = 3600 V | T _j = 125 °C | _ | 900 | _ | Α |
| | | I _C = 1000 A | T _j = 150 °C | _ | 940 | _ | |
| | | $V_{GE} = \pm 15 \text{ V}$ | T _j = 25 °C | _ | _ | _ | |
| Q_{rr} | Reverse recovery charge (Note 2 | $R_{G(on)} = 1.8 \Omega$ | T _j = 125 °C | _ | 1810 | _ | μC |
| | | L _s = 150 nH | T _j = 150 °C | _ | 2070 | _ | |
| | Reverse recovery energy (Note 2) (Note 5) | Inductive load | T _j = 25 °C | _ | _ | _ | |
| E _{rec(10%)} | | , | T _j = 125 °C | _ | 4.00 | _ | J |
| | | | T _j = 150 °C | _ | 4.60 | _ | |
| E _{rec} | (Note 2) | | T _j = 25 °C | _ | _ | _ | |
| | Reverse recovery energy (Note 6 | | T _j = 125 °C | _ | 4.10 | _ | J |
| | | | T _j = 150 °C | _ | 4.70 | _ | |

THERMAL CHARACTERISTICS

| Symbol | lta | Conditions | Limits | | | 1.1 |
|-----------------------|----------------------------|--|--------|-----|------|------|
| | Item | Conditions | Min | Тур | Max | Unit |
| R _{th(j-c)Q} | Thermal resistance | Junction to Case, IGBT part | 1 | _ | 11.0 | K/kW |
| $R_{th(j-c)D}$ | | Junction to Case, FWDi part | 1 | _ | 17.0 | K/kW |
| R _{th(c-s)} | Contact thermal resistance | Case to heat sink, $\lambda_{grease} = 1W/m^*k$, $D_{(c-s)} = 100\mu m$ | _ | 6.0 | _ | K/kW |

MECHANICAL CHARACTERISTICS

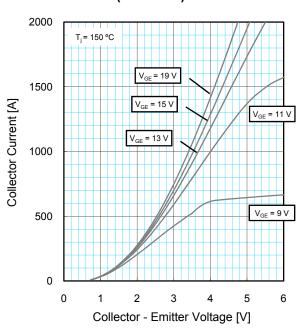
| Symbol | lka m | Conditions Limits Min Typ | | 1.1:4 | | |
|----------------------|----------------------------|--------------------------------|------|-------|------|------|
| | Item | | Min | Тур | Max | Unit |
| M _t | | M8 : Main terminals screw | 7.0 | 1 | 22.0 | N·m |
| Ms | Mounting torque | M6 : Mounting screw | 3.0 | l | 6.0 | N·m |
| Mt | | M4 : Auxiliary terminals screw | 1.0 | - | 3.0 | N⋅m |
| m | Mass | | | 1.4 | 1 | kg |
| CTI | Comparative tracking index | | 600 | 1 | 1 | |
| d _a | Clearance | | 26.0 | l | - | mm |
| ds | Creepage distance | | 56.0 | - | _ | mm |
| L _{P CE} | Parasitic stray inductance | | _ | 15.0 | _ | nΗ |
| R _{CC'+EE'} | Internal lead resistance | T _C = 25 °C | | 0.18 | | mΩ |
| r _g | Internal gate resistance | T _C = 25 °C | _ | 2.6 | _ | Ω |

Note1. Pulse width and repetition rate should be such that junction temperature (T_j) does not exceed T_{jopmax} rating.

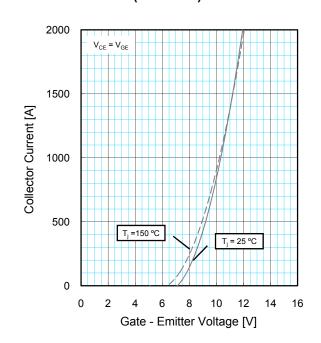
- 2. The symbols represent characteristics of the anti-parallel, emitter to collector free-wheel diode (FWD_i).
- 3. Junction temperature (T_j) should not exceed T_{jmax} rating (150°C).
- 4. Pulse width and repetition rate should be such as to cause negligible temperature rise.
- 5. $E_{on(10\%)}$ / $E_{off(10\%)}$ / $E_{rec(10\%)}$ are the integral of 0.1 V_{CE} x 0.1 I_C x dt.
- 6. Definition of all items is according to IEC 60747, unless otherwise specified.

INSULATED TYPE

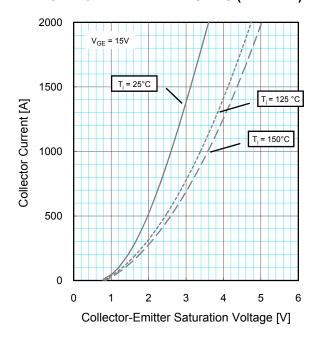
OUTPUT CHARACTERISTICS (TYPICAL)



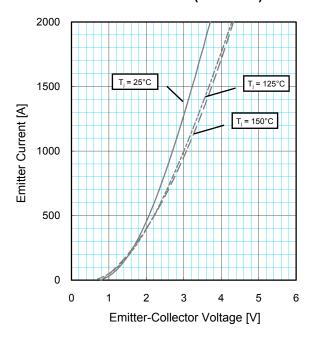
TRANSFER CHARACTERISTICS (TYPICAL)



COLLECTOR-EMITTER SATURATION VOLTAGE CHARACTERISTICS (TYPICAL)

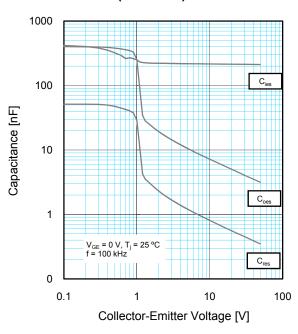


FREE-WHEEL DIODE FORWARD CHARACTERISTICS (TYPICAL)

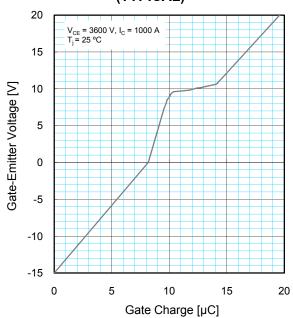


INSULATED TYPE

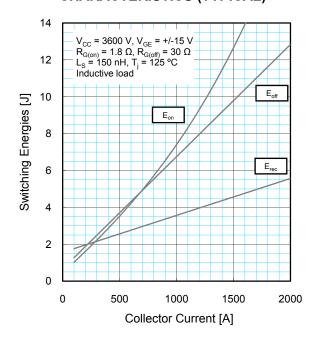
CAPACITANCE CHARACTERISTICS (TYPICAL)



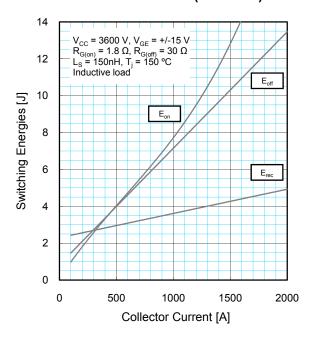
GATE CHARGE CHARACTERISTICS (TYPICAL)



HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)

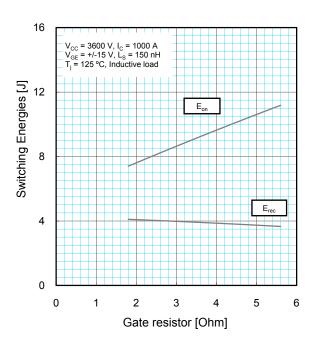


HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)

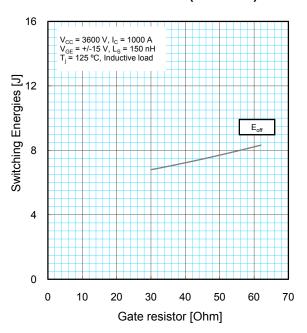


INSULATED TYPE

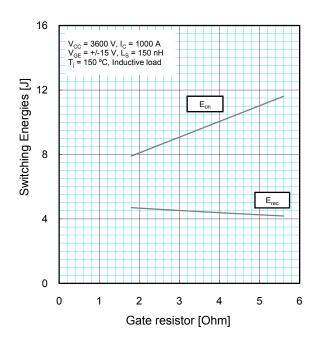
HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



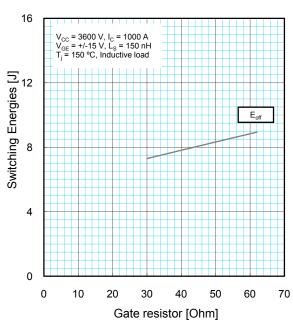
HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)

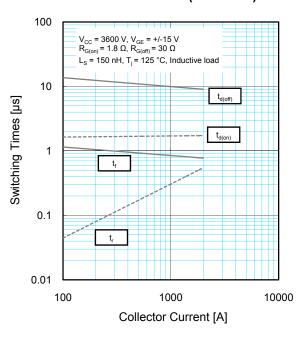


HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)

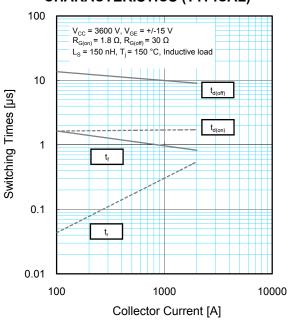


INSULATED TYPE

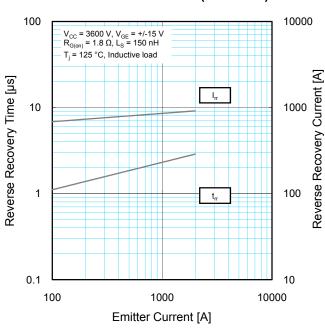
HALF-BRIDGE SWITCHING TIME CHARACTERISTICS (TYPICAL)



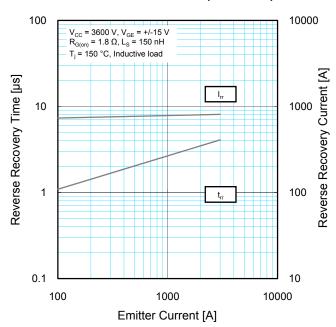
HALF-BRIDGE SWITCHING TIME CHARACTERISTICS (TYPICAL)



FREE-WHEEL DIODE REVERSE RECOVERY CHARACTERISTICS (TYPICAL)

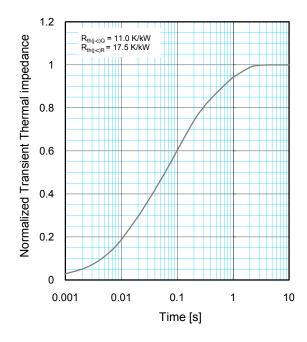


FREE-WHEEL DIODE REVERSE RECOVERY CHARACTERISTICS (TYPICAL)



INSULATED TYPE

TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS



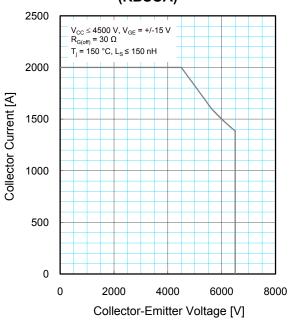
$$Z_{th(j-c)}(t) = \sum_{i=1}^{n} R_{i} \left\{ 1 - exp^{\left(-\frac{t}{\tau_{i}}\right)} \right\}$$

$$\frac{1}{R_{i} [K/kW]: 0.0055} \frac{2}{0.2360} \frac{3}{0.4680} \frac{4}{0.2905}$$

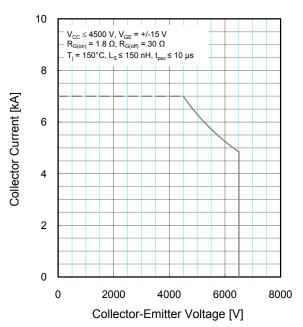
$$\frac{1}{t_{i} [sec]: 0.0001} \frac{3}{0.0131} \frac{4}{0.0878} \frac{3}{0.6247}$$

INSULATED TYPE

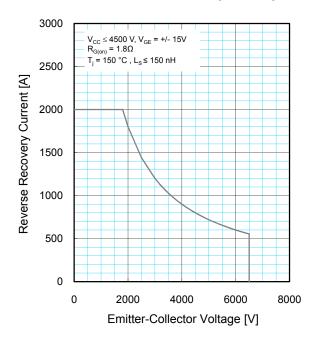
REVERSE BIAS SAFE OPERATING AREA (RBSOA)



SHORT CIRCUIT SAFE OPERATING AREA (SCSOA)



FREE-WHEEL DIODE REVERSE RECOVERY SAFE OPERATING AREA (RRSOA)



5th-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules

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